

**Search Notes**

Application/Control No.

10/523,084

Examiner

Hoang Tran

Applicant(s)/Patent under  
Reexamination

NAKANISHI ET AL.

Art Unit

2874

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search - (US-PGPUB, USPAT, USOCR, EPO, JPO) See Search History Print Out	4/26/2007	HT